

Search Notes

Application/Control No.

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Examiner

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Applicant(s)/Patent under
Reexamination

EKBERG, JAN-ERIK

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
370	386	1/26/2007	HH
707	1	1/26/2007	HH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST image and keyword search in USPATConclusion, US-PGPUB, USOCR, EPO, JPO, DERWENT, IBM_TDB (See attached search strategy)	1/26/2007	HH